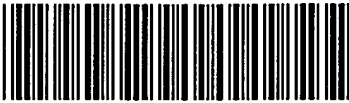


Search Notes

Application/Control No.

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Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

SEKI ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	234-235, 248-250	8/4/2006	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
347	249	8/4/2006	HP
PGPub Text Search		8/4/2006	HP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	8/4/2006	HP